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2.5V Drive Nch+Pch MOSFET

EM6M1

Structure

Silicon N-channel MOSFET / Silicon P-channel MOSFET

● Features

- 1) Nch MOSFET and Pch MOSFET are put in EMT6 package.
- 2) High-speed switching.
- 3) Low voltage drive (2.5V drive).
- 4) Built-in G-S Protection Diode.

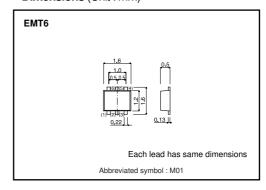
Applications

Switching

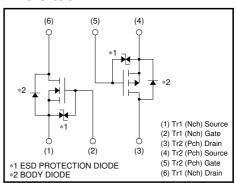
Packaging specifications

	Package	Taping		
Type	Code	T2R		
	Basic ordering unit (pieces)	8000		
EM6M1		0		

● Dimensions (Unit: mm)



•Inner circuit



● Absolute maximum ratings (Ta=25°C)

Parameter		Cumbal	Lin	Unit	
		Symbol	Tr1: N-ch Tr2: P-ch		Offic
Drain-source voltage		V _{DSS}	30	-20	V
Gate-source voltage		V _{GSS}	±20	±12	V
Drain current	Continuous	lσ	±0.1 ±0.2		Α
	Pulsed	I _{DP} *1	±0.4 ±0.4		Α
Power dissipation		P _D *2	15	mW / TOTAL	
		ט ו	12	mW / ELEMENT	
Channel temperature		Tch	150		°C
Range of storage temperature		Tstg	-55 to +150		°C

^{*1} Pw ≦10μs, Duty cycle ≦1% *2 Mounted on a ceramic board

●Notice

This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

ROHM

N-ch

●Electrical characteristics (Ta=25°C)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Gate-source leakage	Igss	-	-	±1	μА	V _{GS} = ±20V, V _{DS} =0V
Drain-source breakdown voltage	V _(BR) DSS	30	-	_	٧	I _D =10μA, V _{GS} =0V
Zero gate voltage drain current	IDSS	_	-	1	μА	VDS=30V, VGS=0V
Gate threshold voltage	V _{GS (th)}	8.0	-	1.5	٧	V _{DS} =3V, I _D =100μA
Static drain-source on-state resistance	Page *	_	5	8	Ω	I _D =10mA, V _{GS} =4V
	R _{DS (on)}	-	7	13	Ω	I _D =1mA, V _{GS} =2.5V
Forward transfer admittance	Y _{fs} *	20	-	_	mS	V _{DS} =3V, I _D =10mA
Input capacitance	Ciss	_	13	_	pF	V _{DS} =5V
Output capacitance	Coss	_	9	_	pF	V _{GS} =0V
Reverse transfer capacitance	Crss	-	4	_	pF	f=1MHz
Turn-on delay time	t d (on) *	_	15	_	ns	V _{DD} ≒5V
Rise time	tr *	_	35	_	ns	ID=10mA
Turn-off delay time	td (off) *	_	80	_	ns	V _{GS} =5V R _L =500Ω
Fall time	t _f *	-	80	_	ns	R _G =10Ω
Total gate charge	Qg *	_	0.9	-	nC	V _{DD} ≒ 15V, I _D =0.1A
Gate-source charge	Qgs *	_	0.2	_	nC	V _{GS} =4.5V
Gate-drain charge	Q _{gd} *	_	0.2	_	nC	$R_L=150\Omega$, $R_G=10\Omega$

^{*}Pulsed

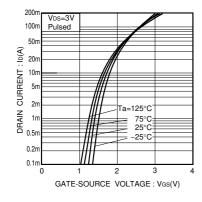
P-ch
●Electrical characteristics (Ta=25°C)

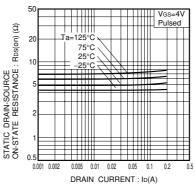
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions	
Gate-source leakage	Igss	-	_	±10	μΑ	V _{GS} = ±12V, V _{DS} =0V	
Drain-source breakdown voltage	V(BR) DSS	-20	_	_	٧	ID= -1mA, VGS=0V	
Zero gate voltage drain current	IDSS	-	-	-1	μΑ	V _{DS} = -20V, V _{GS} =0V	
Gate threshold voltage	V _{GS (th)}	-0.7	_	-2.0	V	$V_{DS} = -10V, I_{D} = -1mA$	
Static drain-source on-state resistance	RDS (on)	_	1.0	1.5	Ω	I _D = -0.2A, V _G S= -4.5V	
		_	1.1	1.6	Ω	I _D = -0.2A, V _G S= -4V	
		-	2.0	3.0	Ω	I _D = -0.2A, V _G S= -2.5V	
Forward transfer admittance	Y _{fs} *	0.2	_	_	S	$V_{DS} = -10V$, $I_{D} = -0.15A$	
Input capacitance	Ciss	_	50	_	рF	V _{DS} = -10V	
Output capacitance	Coss	_	5	_	pF	V _{GS} = 0V	
Reverse transfer capacitance	Crss	-	5	_	рF	f=1MHz	
Turn-on delay time	t d (on) *	-	9	_	ns	V _{DD} ≒ –15V	
Rise time	tr *	-	6	_	ns	I _D = -0.15A V _{GS} = -4.5V R _L = 100Ω	
Turn-off delay time	t _{d (off)} *	_	35	_	ns		
Fall time	t _f *	_	45	_	ns	R _G = 10Ω	
Total gate charge	Qg *	-	1.2	_	nC	V _{DD} ≒-15V, I _D =-0.2A	
Gate-source charge	Q _{gs} *	_	0.2	_	nC	V _{GS} = -4.5V	
Gate-drain charge	Q _{gd} *	_	0.2	_	nC	$R_L=75\Omega$, $R_G=10\Omega$	

^{*}Pulsed

N-ch

•Electrical characteristic curve





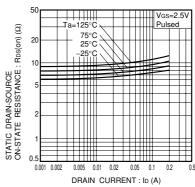


Fig.1 Typical Transfer Characteristics

Fig.2 Static Drain-Source On-State Resistance vs. Drain Current (I)

Fig.3 Static Drain-Source On-State Resistance vs. Drain Current (II)

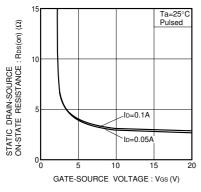


Fig.4 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

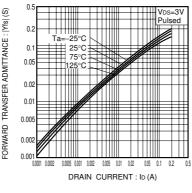


Fig.5 Forward Transfer Admittance vs. Drain Current

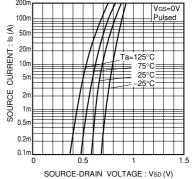


Fig.6 Reverse Drain Current vs. Source-Drain Voltage (I)

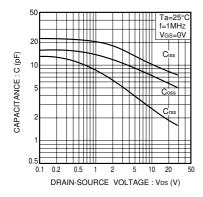


Fig.7 Typical Capacitance vs. Drain-Source Voltage

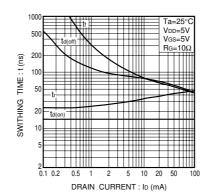
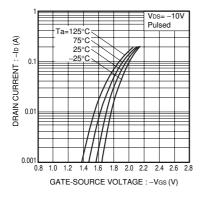
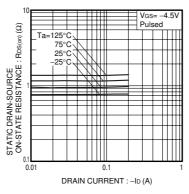


Fig.8 Switching Characteristics

P-ch

•Electrical characteristic curve





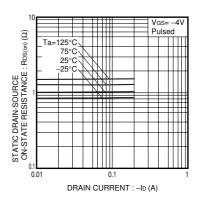
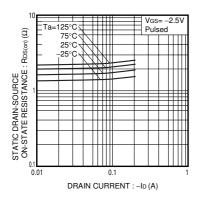
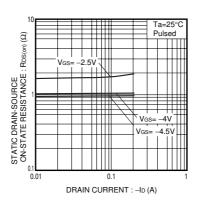


Fig.1 Typical Transfer Characteristics

Fig.2 Static Drain-Source On-State Resistance vs. Drain Current (I)

Fig.3 Static Drain-Source On-State Resistance vs. Drain Current (II)





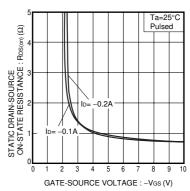
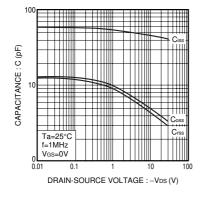
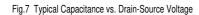


Fig.4 Static Drain-Source On-State Resistance vs. Drain Current (III)

Fig.5 Static Drain-Source On-State Resistance vs. Drain Current (IV)

Fig.6 Static Drain-Source On-State Resistance vs. Gate-Source Voltage





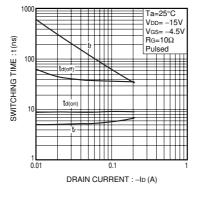


Fig.8 Switching Characteristics

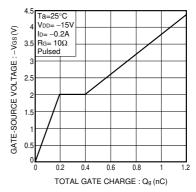


Fig.9 Dynamic Input Characteristics

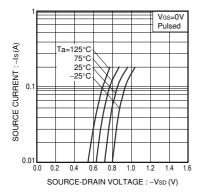


Fig.10 Source Current vs. Source-Drain Voltage

N-ch

●Measurement circuit

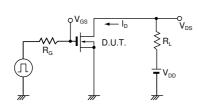


Fig.9 Switching Time Test Circuit

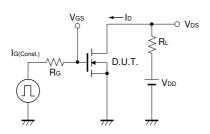


Fig.11 Gate Charge Measurement Circuit

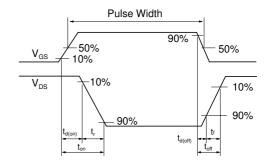


Fig.10 Switching Time Waveforms

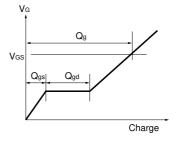


Fig.12 Gate Charge Waveform

P-ch

●Measurement circuit

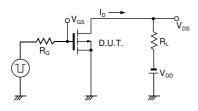


Fig.11 Switching Time Test Circuit

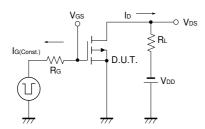


Fig.13 Gate Charge Measurement Circuit

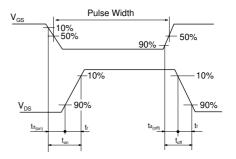


Fig.12 Switching Time Waveforms

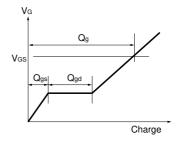


Fig.14 Gate Charge Waveform

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